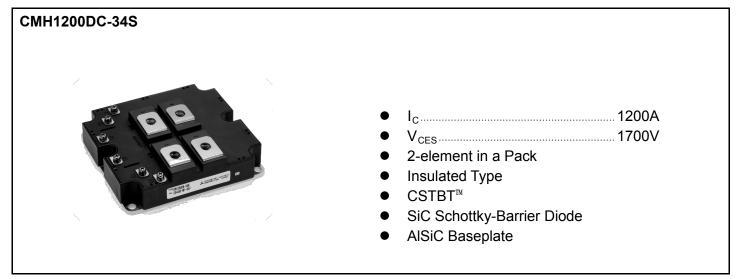


< HVIGBT MODULE > CMH1200DC-34S

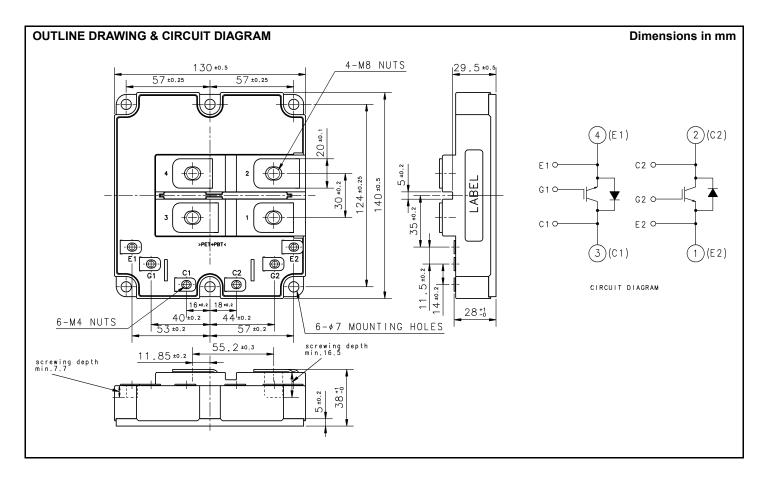
HIGH POWER SWITCHING USE INSULATED TYPE

SiC Hybrid HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Module



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



< HVIGBT MODULE > CMH1200DC-34S HIGH POWER SWITCHING USE INSULATED TYPE

SiC Hybrid HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Module

MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V _{CES}	Collector-emitter voltage	V _{GE} = 0V	1700	V
V_{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	±20	V
lc	Collector overent	DC, T _c = 110°C	1200	Α
I CRM	Collector current	Pulse (Note 1)	2400	А
Ι _Ε		DC	1200	А
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	2400	А
l ² t	Surge current load integral	$T_j = 125^{\circ}C, V_R = 0V, t_p = 10ms$	—	kA ² s
P _{tot}	Maximum power dissipation (Note 3)	T _c = 25°C, IGBT part	6750	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1min.	4000	V
T _{jop}	Operating junction temperature		-50 ~ +150	°C
T _{stg}	Storage temperature		-50 ~ +150	°C
t _{psc}	Short circuit pulse width	V _{CC} = 1200 V, V _{CE} ≤ V _{CES} , V _{GE} = 15V, T _j = 150°C	10	μs

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
Symbol	item			Min	Тур	Max	Unit
I _{CES}			T _j = 25°C	_	36	—	
	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T _j = 125°C	-	150	_	mA
			T _j = 150°C		180	—	
V _{GE(th)}	Gate-emitter threshold voltage	V _{CE} = 10V, I _C = 120mA, T _j = 25°C		—	6.0	—	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^{\circ}C$		-0.5	_	0.5	μA
Cies	Input capacitance	V _{CE} = 10V, V _{GE} = 0V, f = 100kHz			216	_	nF
Coes	Output capacitance				8.0	_	nF
C _{res}	Reverse transfer capacitance	$T_j = 25^{\circ}C$			1.6	_	nF
Q _G	Total gate charge	V _{CC} = 850V, I _C = 1200A, V _{GE} = 15V		_	12.0	_	μC
		L = 1200 A	T _j = 25°C		1.95	_	
V _{CEsat}	Collector-emitter saturation voltage	$I_{\rm C} = 1200 {\rm A}$ (Note 4)	T _j = 125°C		2.25		V
	_	V _{GE} = 15 V	T _i = 150°C	_	2.30	_	
			T _i = 25°C		0.50		μs
t _{d(on)}	Turn-on delay time		T _i = 125°C		0.50	_	
		V _{CC} = 850 V	T _i = 150°C		0.50	_	
	Turn-on rise time	I _C = 1200 A	T _i = 25°C		0.14	_	μs
tr		$V_{GE} = \pm 15 V$	T _i = 125°C		0.15	_	
		$R_{G(on)} = 1.3 \Omega$	T _i = 150°C	_	0.15	_	
	Turn-on switching energy (Note 5)	L _s = 100 nH	T _i = 25°C	_	110	_	mJ
Eon		Inductive load	T _i = 125°C	_	135	_	
	6 6,		T _i = 150°C	_	140	_	
	Turn-off delay time		T _i = 25°C	_	1.25		μs
t _{d(off)}			T _i = 125°C	_	1.35	_	
- ((()))		V _{CC} = 850 V	T _i = 150°C		1.35	_	P -
		I _C = 1200 A	T _i = 25°C	_	0.30		
t _f	Turn-off fall time	$V_{GE} = \pm 15 V$	T _i = 125°C	_	0.55		μs
-1		$R_{G(off)} = 3.3 \Omega$	T _i = 150°C	_	0.60		1
		$L_s = 100 \text{ nH}$	$T_i = 25^{\circ}C$	_	250	_	
E _{off}	Turn-off switching energy (Note 5)	Inductive load	$T_i = 125^{\circ}C$	_	370	_	mJ
			$T_i = 150^{\circ}C$	_	390	_	
V _{EC}	Emitter-collector voltage (Note 2)	I _E = 1200A (Note 4)	$T_i = 25^{\circ}C$	_	1.60	_	
			$T_i = 125^{\circ}C$	_	2.20	_	V
		$V_{GE} = 0V$	$T_i = 150^{\circ}C$	_	2.30	_	ž
	Total capacitive charge (Note 2,6)		$T_i = 25^{\circ}C$	_	5.0	_	
Qc		V _{CC} = 850V, I _E = 1200 A	$T_i = 125^{\circ}C$	_	8.5		μC
		$R_{G(on)} = 1.3\Omega, L_s = 100 \text{ nH}$	$T_i = 150^{\circ}C$	_	9.0	_	~~
			.,]	0.0	1	<u> </u>

< HVIGBT MODULE > CMH1200DC-34S HIGH POWER SWITCHING USE INSULATED TYPE

SiC Hybrid HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Module

THERMAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
Symbol				Тур	Max	Unit
R _{th(j-c)Q}	Thermal resistance	Junction to Case, IGBT part, 1/2 module	—		18.5	K/kW
R _{th(j-c)D}	Thermal resistance	Junction to Case, FWDi part, 1/2 module	—		36.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, 1/2 module λ_{grease} = 1W/m [•] k, D _(c-s) = 100 μ m	—	16.0		K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Que d'élie e c	Limits			1.1
		Conditions	Min	Тур	Max	Unit
Mt		Main terminals screw	7.0	—	20.0	N∙m
Ms	Mounting torque	Mounting screw	3.0	_	6.0	N∙m
Mt		Auxiliary terminals screw	1.0	_	3.0	N∙m
m	Mass			0.8	—	kg
CTI	Comparative tracking index		600	_	_	_
da	Clearance		9.5	—	—	mm
ds	Creepage distance		15.0	_	_	mm
LPCE	Parasitic stray inductance	1/2 module	_	30.0	_	nH
R _{CC'+EE'}	Internal lead resistance	$T_c = 25^{\circ}C$, 1/2 module	_	0.28	_	mΩ

Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).

3. Junction temperature (T_j) should not exceed T_{jmax} rating.

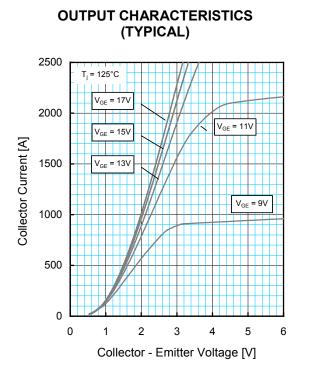
4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

5. Definition of all items is according to IEC 60747, unless otherwise specified.

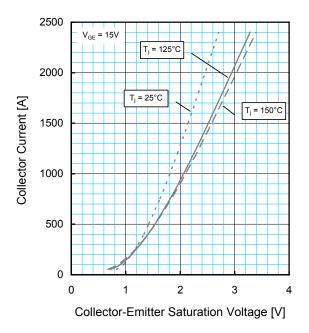
6. Capacitive charge during anti-paralleled FWDi's turn-off operation.

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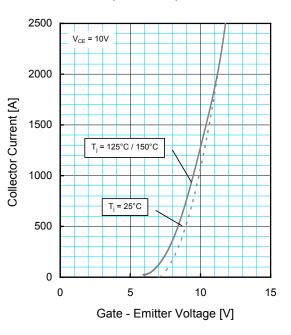
PERFORMANCE CURVES



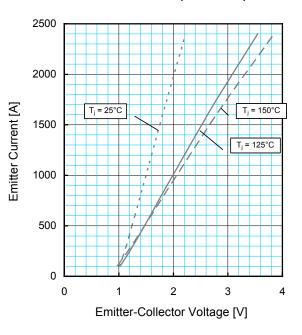
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



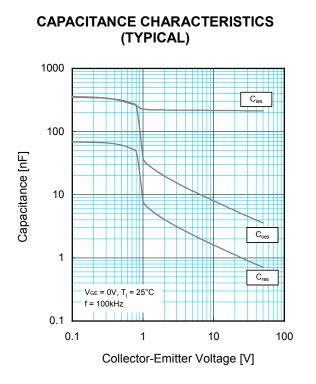
TRANSFER CHARACTERISTICS (TYPICAL)



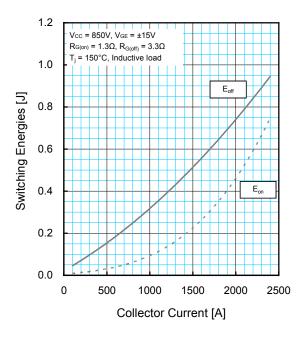
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



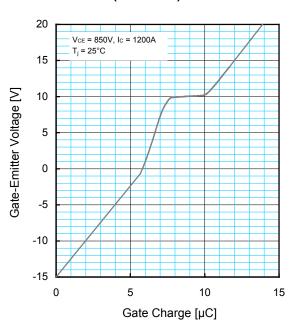
PERFORMANCE CURVES



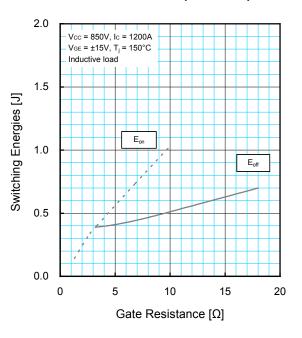
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



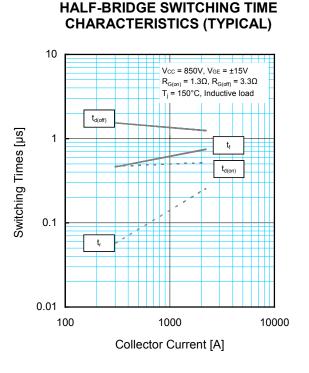
GATE CHARGE CHARACTERISTICS (TYPICAL)



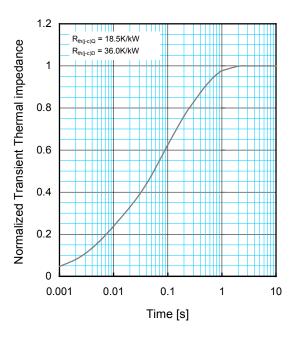
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



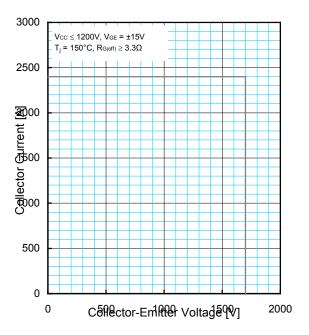
PERFORMANCE CURVES



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



REVERSE BIAS SAFE OPERATING AREA (RBSOA)



$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$								
	1	2	3	4				
R _i [K/kW]	0.0096	0.1893	0.4044	0.3967				
t _i [sec]	0.0001	0.0058	0.0602	0.3512				

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